# ΗΙΟΚΙ

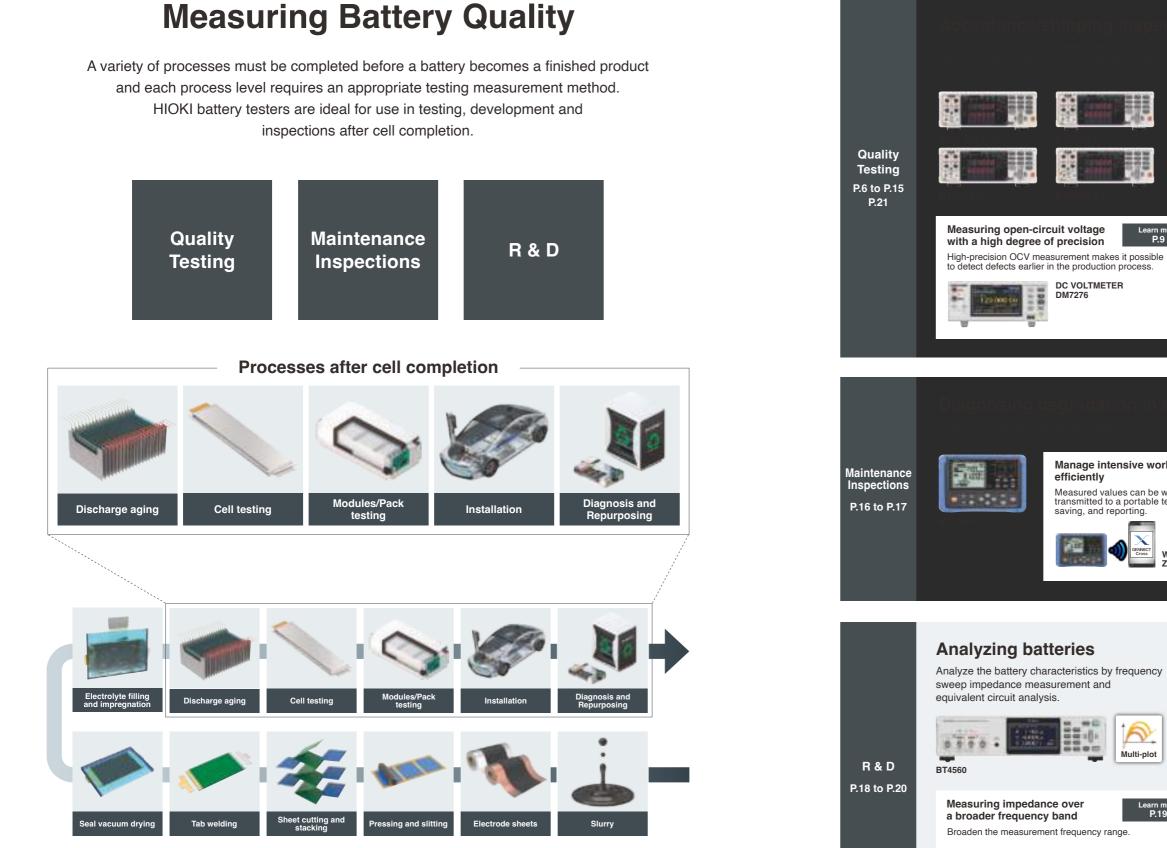
## BATTERY TESTER Series

## **Measuring Battery Quality**

Cells - Modules - Packs

## Quality Testing Maintenance Inspections R & D





Lithium-ion Battery Production Processes



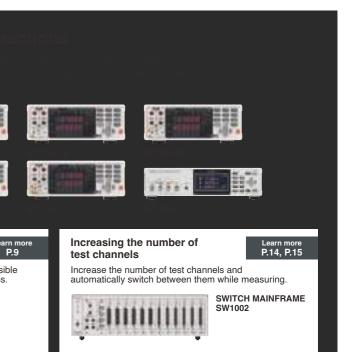
## **Analyzing batteries**

Analyze the battery characteristics by frequency sweep impedance measurement and



earn mor P.19

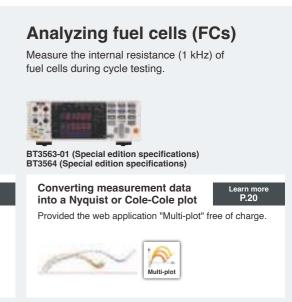




## Fit in tight spaces for speedy

The tip is L-shaped for ease of use when nspecting batteries installed in tight





## **Battery tester lineup**

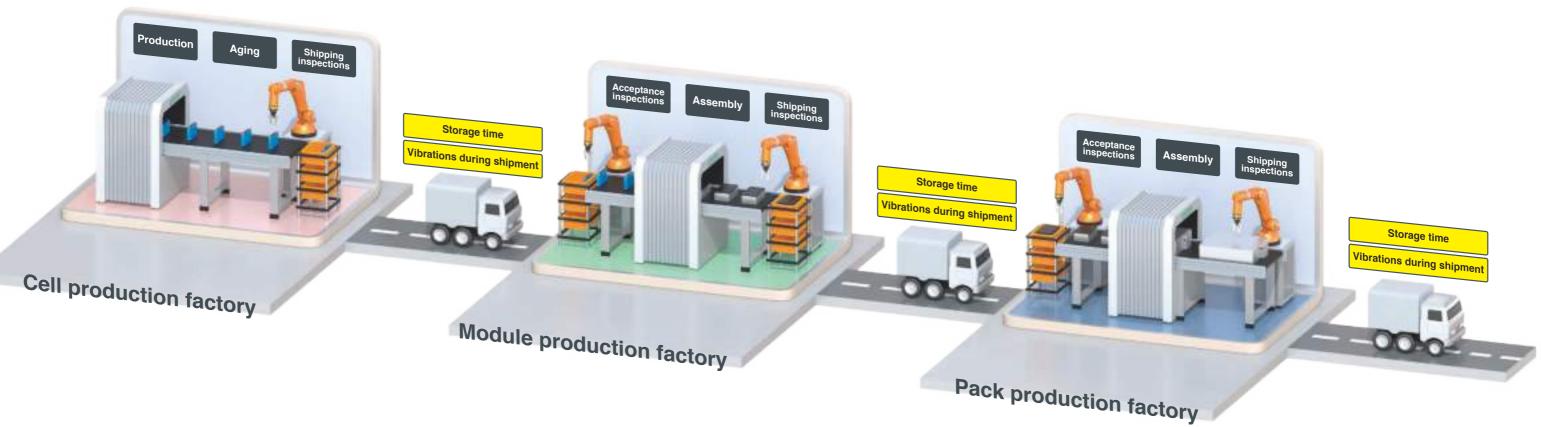
			Acceptance/ship	ping inspections	
Application		Small cells for general purpose High speed sorting	Small cells for power motors Small packs of up to 60 V	Large cells for xEVs Mid-sized packs of up to 100 V	Large packs for xEVs Large packs of up to 300 V
Model		3561, 3561-01	BT3561A	BT3562A	BT3563A
Appearance					
Measurement method		AC four-terminal method	AC four-terminal method	AC four-terminal method	AC four-terminal method
Measurement frequency		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz
Rated input voltage		±22 V DC	±60 V DC	±100 V DC	±300 V DC
Maximum rated voltage to ea	rth	±60 V DC	±60 V DC	±100 V DC	±300 V DC
	3 mΩ	N/A	N/A	$3.1000~m\Omega,0.1~\mu\Omega,100~mA$	3.1000 mΩ, 0.1 μΩ, 100 mA
Resistance	30 mΩ	N/A	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 $\mu\Omega,$ 100 mA	31.000 mΩ, 1 μΩ, 100 mA
measurement ranges	300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA
	3Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA
Max. display, resolution,	30 Ω	N/A	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μΑ
MAX. display, resolution, measurement current	300 Ω	N/A	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μΑ
current	3 kΩ 3 mΩ	N/A	3.1000 kΩ, 100 mΩ, 10 μA	3.1000 kΩ, 100 mΩ, 10 μA	3.1000 kΩ, 100 mΩ, 10 μA
	3 mΩ range 30 mΩ	N/A	N/A	±0.5% rdg ±10 dgt	±0.5% rdg ±10 dgt
Voltage measurement	range or more	±0.5% rdg ±5 dgt	±0.5% rdg ±5 dgt	±0.5% rdg ±5 dgt	±0.5% rdg ±5 dgt
surg	6 V	N/A	6.000 00 V,10 μV	6.000 00 V,10 μV	6.000 00 V, 10 μV
w Voltage measurement	20 V 60 V	19.999 9 V, 100 μV N/A	N/A	N/A	N/A
ranges	100 V	N/A N/A	60.000 0 V, 100 μV N/A	60.000 0 V, 100 μV 100.000 V, 1 mV	60.000 0 V, 100 μV N/A
Max. display,	300 V	N/A	N/A	N/A	300.000 V, 1 mV
resolution	1000 V	N/A	N/A	N/A	N/A
Basic accu		±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt
Response time <sup>*1</sup>	,	3 ms	10 ms	10 ms	10 ms
Sampling period "2	Ω or V	4 ms, 12 ms, 35 ms, 150 ms	4 40 05 450		4
	22 UI V	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms
EX.FAST, FAST, MEDIUM, SLOW	ΩV	7 ms, 23 ms, 69 ms, 252 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms
	ΩV		. , ,		· · ·
EX.FAST, FAST, MEDIUM, SLOW	ΩV	7 ms, 23 ms, 69 ms, 252 ms	8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 ms
EX.FAST, FAST, MEDIUM, SLOW Allowable total line resistance "1" (error detection)	ΩV <sup>3</sup> SENSE line SOURCE line	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω
EX.FAST, FAST, MEDIUM, SLOW Allowable total line resistance '1 ' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage	ΩV       3     SENSE line       SOURCE line       1 Ω or more	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/ RS-232C '4 (Max, 38400 b)	ΩV           3         SENSE line           SOURCE line           3         Ω or more           00BASE-TX)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/ RS-232C '4 (Max, 38400 b)	ΩV           3         SENSE line           SOURCE line           3         Ω or more           00BASE-TX)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/ RS-232C "4 (Max. 38400 b) USB GP-IB	ΩV           3         SENSE line           SOURCE line           3         Ω or more           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/ RS-232C "4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in	ΩV           3         SENSE line           SOURCE line           30 or more           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin)	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A N/A YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES V/A N/A YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to	ΩV           3         SENSE line           SOURCE line           30 or more           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A N/A YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check	ΩV           3         SENSE line           SOURCE line           3 0 or more           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A N/A YES YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES YES YES
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance <sup>11,7</sup> (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/ RS-232C <sup>-14</sup> (Max. 38400 b USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES YES	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES YES YES YES YES
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES (3561-01 Only) YES (36-pin) N/A YES YES YES N/A	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES YES YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES YES YES YES YES YES YES
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES YES N/A Hi/ IN/ Lo	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES YES Hi/ IN/ Lo	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES YES Hi/ IN/ Lo	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES Hi/ IN/ Lo
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES YES N/A Hi/ IN/ Lo Max. 30,000	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES YES N/A Hi/ IN/ Lo Max. 30,000	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES N/A N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Den terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Copen terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω RS-232C '4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c) Measurement current puls Comparator Statistical calculations Delay Average	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance '1' (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/' RS-232C '4 (Max. 38400 b USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading Memory storage	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω ILAN (TCP/IP, 10BASE-T/- RS-232C "4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading Memory storage LabVIEW® driver "5	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)   Interface)           3.1 V)   pounts) se output	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010
EX.FÁST, FÁST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Den terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Den terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading Memory storage LabVIEW <sup>®</sup> driver '5 Applicable standards Effect of radiated radio-freque electromagnetic field Effect of conducted	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)   Interface)           3.1 V)   pounts) se output	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61010 EMC: EN61010	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A N/A YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61010 EMC: EN61010	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mQ, 30 mQ, 300 mQ, 3 Q Open terminal voltage Ranges: 30 mQ or less, 300 mQ, 3 Q Open terminal voltage Ranges: 30 mQ or less, 300 mQ, 3 Q UPENTIAL AN (TCP/IP, 10BASE-T/T RS-232C "4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading Memory storage LabVIEW® driver "5 Applicable standards Effect of radiated radio-freque electromagnetic field	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES N/A Hi/ IN/ L0 Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup>	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant ' <sup>6</sup>	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ L0 Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '8	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>'6</sup>
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Den terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω LAN (TCP/IP, 10BASE-T/ RS-232C "4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading Memory storage LabVIEW® driver "5 Applicable standards Effect of radiated radio-freque electromagnetic field	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)   Interface)           3.1 V)   ounts) se output           counts)   ency           10 V	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES YES N/A Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup> N/A	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A N/A YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup> Resistant	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup>	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>*6</sup> Resistant
EX.FÅST, FÅST, MEDIUM, SLOW Allowable total line resistance "1" (error detection) Ranges: 3 mΩ, 30 mΩ, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Den terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ, 3 Ω ILAN (TCP/IP, 10BASE-T/ RS-232C "4 (Max. 38400 b) USB GP-IB EXT I/O (37-pin Handler in Analog output (DC 0 V to Contact check Zero adjustment (±1000 c Measurement current puls Comparator Statistical calculations Delay Average Panel saving/loading Memory storage LabVIEW® driver "5 Applicable standards Effect of radiated radio-freque electromagnetic field Effect of conducted radiofrequency electromagnetic field	ΩV           3         SENSE line           SOURCE line           100BASE-TX)           ps)   Interface)           3.1 V)   ounts) se output           counts)   ency           10 V	7 ms, 23 ms, 69 ms, 252 ms N/A, N/A, 20 Ω, 20 Ω N/A, N/A, 50 Ω, 500 Ω N/A, 7 V, 7 V peak N/A YES N/A YES (3561-01 Only) YES (36-pin) N/A YES (36-pin) N/A YES (36-pin) N/A YES (36-pin) N/A YES 2 to 10 nt Max. 30,000 YES 2 to 16 times 126 400 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup> N/A Resistant	8 ms, 24 ms, 70 ms, 253 ms N/A, 6.5 Ω, 30 Ω, 30 Ω N/A, 5.5 Ω, 15 Ω, 15 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>78</sup> Resistant	8 ms, 24 ms, 70 ms, 253 ms           6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω           5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω           25 V, 7 V, 4 V peak           YES           YES           N/A           N/A           YES           2 to 16 times           126           400           YES           Safety: EN61010           EMC: EN61326 Class A           Resistant '8           Resistant '8	8 ms, 24 ms, 70 ms, 253 ms 6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω 5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak YES YES N/A N/A N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant "6 Resistant Resistant

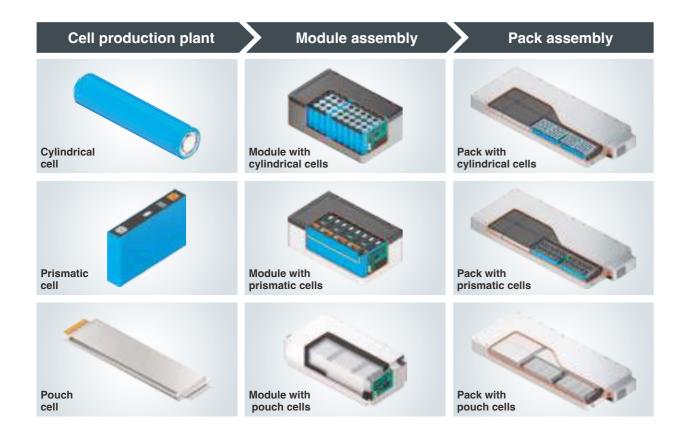
\*1: Typical value \*2: When the power supply frequency is 60 Hz \*3: Total line resistance = wiring resistance + contact resistance + DUT resistance \*4: Available as printer I/F \*5: LabVIEW® Driver is a registered trademark of National Instruments Corporation \*6: Test conditions were 80 MHz to 1 GHz at 10 V/m and 1 GHz to 6 GHz at 3 V/m, all at 80% AM \*7: Canadian Standards Assosiation

		Acceptance/ship	ping inspections	R & D	Maintenance	
Application			Extra large packs for xEV, ESS 1000 V high voltage model	GP-IB model	Cells Degree of deterioration for reuse	Large-scale UPS
Model Appearance		BT3564	BT3562-01 BT3563-01	BT4560	BT3554-50	
				(11). III III		
Measurement metho	bd		AC four-terminal method	AC four-terminal method	AC four-terminal pair method	AC four-terminal metho
Measurement freque	ency		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	0.10 Hz to 1050 Hz	1 kHz ±80 Hz
Rated input voltage			±1000 V DC	BT3562-01: ±70 V DC BT3563-01: ±300 V DC	±5 V DC	±60 V DC
Maximum rated volta	age to eart	h	±1000 V DC	BT3562-01: ±60 V DC BT3563-01: ±300 V DC	SOURCE-H, SENSE-H: ±5 V DC SOURCE-L, SENSE-L: 0 V DC	±60 V DC
		3 mΩ	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA	Resistance (R)	
Resistance		30 mΩ	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	3.6000 mΩ, 0.1 μΩ, 1.5 A 12.0000 mΩ, 0.1 μΩ, 500 mA	Resistance (R)
measurement ranges		300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	120.000 mΩ, 1 μΩ, 50 mA	3.100 mΩ, 1 μΩ, 160 mA 31.00 mΩ, 10 μΩ, 160 mA
Ŭ		3Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	[The number of waveforms] Frequency: FAST, MEDIUM, SLOW	310.0 mΩ, 100 μΩ, 16 m/
Max. display,		30 Ω	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μΑ	0.10 Hz to 66 Hz: 1 wave, 2 waves, 8 waves	3.100 Ω, 1 mΩ, 1.6 mA [Basic accuracy]
e measurement		300 Ω	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μΑ	67 Hz to 250 Hz: 2 waves, 8 waves, 32 waves 260 Hz to 1050 Hz: 8 waves, 32 waves, 128 waves	±1.0% rdg ±8 dgt
current		3 kΩ 3 mΩ	3.1000 kΩ, 100 mΩ, 10 μA	3.1000 kΩ, 100 mΩ, 10 μA	Reactance (X)	(3 mΩ range) ±0.8% rdg ±6 dgt
	asic ccuracy	range	±0.5% rdg ±10 dgt *8	±0.5% rdg ±10 dgt	±3.6000 mΩ, 0.1 μΩ, 1.5 A ±12.0000 mΩ, 0.1 μΩ, 500 mA	$\pm 0.8\%$ rdg $\pm 6$ dgt (30 m $\Omega$ range or more)
	ccuracy	30 mΩ range or more	±0.5% rdg ±5 dgt *8	±0.5% rdg ±5 dgt	±120.000 mΩ, 1 μΩ, 50 mA	Voltage (V)
voltage		6 V 10 V	N/A 9.999 99 V, 10 μV	6.000 00 V, 10 μV N/A	<b>Impedance (Ζ)</b> 3.6000 mΩ, 0.1 μΩ, 1.5 A	6.000 V, 1 mV
measurement		60 V	Ν/Α	60.000 0 V, 100 μV	12.0000 mΩ, 0.1 μΩ, 500 mA	60.00 V, 10 mV [Basic accuracy]
ranges		100 V	99.999 9 V, 100 µV	N/A	120.000 mΩ, 1 μΩ, 50 mA <b>Phase angle (θ)</b>	$\pm 0.08\%$ rdg $\pm 6$ dgt
Max. display,		300 V	N/A	300.000 V, 1 mV (BT3563-01 only)	±180.000°, 0.001°	Temperature (°C)
resolution		1000 V	1100.00 V, 1 mV '9	N/A	[Basic accuracy] Refer to P.19 Voltage (V)	-10.0°C to 60.0°C, 0.1°C
В	asic accur	acy	±0.01% rdg ±3 dgt "8	±0.01% rdg ±3 dgt	±5.10000 V, 10 μV	
Response time *1			700 ms	10 ms	[Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period]	1.6 s
Sampling period "2		$\Omega$ or $V$	N/A, 12 ms, 35 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms	FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s	N/A
EX.FAST, FAST, MEDIU	IM, SLOW	ΩV	N/A, 28 ms, 74 ms, 359 ms	8 ms, 24 ms, 70 ms, 253 ms	Temperature (°C)	100 ms
Allowable total line resi	istance "1 "3	SENSE line	3 Ω, 3 Ω, 20 Ω, 20 Ω	2 Ω, 2 Ω, 15 Ω, 15 Ω	-10.0°C to 60.0°C, 0.1°C Allowable total line resistance 13	N/A
(error detection) Ranges: 3 mΩ, 30 mΩ, 300	0 mΩ, 3 Ω	SOURCE line	3 Ω, 3 Ω, 20 Ω, 200 Ω	2 Ω, 2 Ω, 15 Ω, 150 Ω	<b>(error detection)</b> 3 mΩ, 10 mΩ, 100 mΩ	N/A
Open terminal voltag Ranges: 30 mΩ or less,		Ω or more	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	SENSE line: 10 $\Omega,$ 15 $\Omega,$ 50 $\Omega$ SOURCE line: 1.5 $\Omega,$ 4 $\Omega,$ 45 $\Omega$	5 V max
LAN (TCP/IP, 108	BASE-T/10	00BASE-TX)	N/A	N/A	N/A	• USB
RS-232C *4 (Max.	. 38400 bp	s)	YES	YES	YES	Wireless communication
USB			N/A	N/A	YES	(*when Z3210 installed)
GP-IB	In a dia dia dia	(and a set)	YES	YES	N/A	Memory function
EXT I/O (37-pin H		· · · · ·	YES	YES	YES N/A	(Up to 6000 data) • Auto memory function
Analog output (D Contact check	JO U V 10 3	5. I VJ	YES	YES	YES	<ul> <li>Auto-hold function</li> </ul>
Zero adjustment	(±1000 co	unts)	YES	YES	YES *10	<ul> <li>Measurement Navigator (When using Z3210,</li> </ul>
Measurement cu	(	,	YES	YES	YES	GENNECT Cross
Comparator			Hi/ IN/ Lo	Hi/ IN/ Lo	Hi/ IN/ Lo	: Voice guide output) • Auto power-off
Statistical calcula	ations		Max. 30,000	Max. 30,000	N/A	Tablet app
Delay			YES	YES	YES	(GENNECT Cross) • PC app
Average			2 to 16 times	2 to 16 times	1 to 99 times	(GENNECT One) • Comparator function
Panel saving/load	ding		126	126	126	(PASS/ WARNING/ FAIL)
Memory storage			400	400	N/A	<ul> <li>Excel<sup>®</sup> Direct Input functi (When using Z3210)</li> </ul>
LabVIEW <sup>®</sup> driver	*5		N/A	YES	YES	
Applicable standards	6		Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class E
Effect of radiated rad electromagnetic field		псу	Resistant *6	Resistant '6	Resistant '6	Resistant (3 V/m)
Effect of conducted radiofrequency		10 V	N/A	N/A	N/A	N/A
electromagnetic field	i	3 V	Resistant	Resistant	Resistant	N/A
			YES	YES	YES	YES
CE						
CE CSA '7			N/A	YES	N/A	N/A

\*8: Average function: When set to ON 4 times \*9: Resolution 10 mV for 1000.00 V or more \*10: Zero-adjustment range R: ±0.1000 mΩ (3 mΩ range), ±0.3000 mΩ (10 mΩ range), ±3.000 mΩ (100 mΩ range), X: ±1.5000 mΩ (Common for all ranges), V: ±0.10000 V 6

## Measuring battery performance and safety





## Measuring battery performance and safety using internal resistance (AC-IR) and open-circuit voltage (OCV)

Testing plays an important role in production processes by allowing plants to manufacture safe, high-performance batteries. During shipping and acceptance inspections, technicians assess battery performance by measuring internal resistance and safety by measuring open-circuit voltage.

Our Battery testers meet these needs...

"We want to manufacture batteries with stable performance."

"We want to manufacture highly safe batteries."

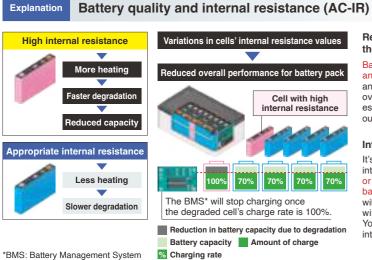
## Assembly process (from cell batteries to pack batteries)

Cells produced at the cell production factory are shipped to the module production factory after undergoing a shipping inspection. Since factors such as vibrations during shipment and even the passage of time can cause defects, batteries undergo an acceptance inspection before being assembled into modules and packs.

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

## Measuring battery performance and safety

## Manufacturing batteries with stable performance



### Relationship between the internal resistance and the decline of battery cell capacity

Battery cells with high internal resistance tend to generate more heat and degrade faster. When cells degrade, their capacity declines, and their internal resistance rises. Internal resistance also changes over time or as a consequence of vibrations during shipment. It's essential to eliminate cells with high internal resistance by carrying out an inspection each time cells are shipped or received.

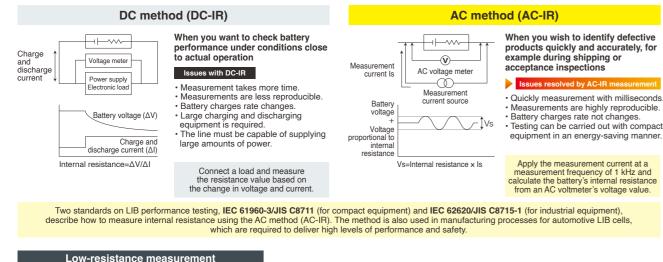
#### Internal resistance and battery pack performance

It's important that all the cells in a given battery pack have uniform internal resistance. If one or more cells have high internal resistance or have degraded, they will become a bottleneck and limit the battery pack's capacity. Moreover, the battery pack's performance will rapidly decline as the BMS\* attempts to protect degraded cells with reduced capacity from overcharging and over-discharging. You can improve battery cell quality by selecting cells with uniform internal resistance so that they will degrade uniformity.

Internal resistance measurement (AC-IR measurement)

### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

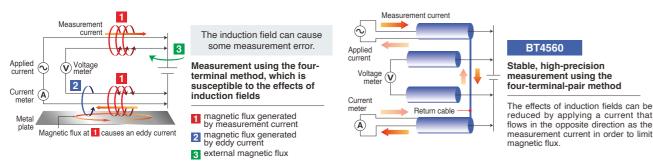
There are two methods for measuring a battery's internal resistance: the AC method and the DC method. Resistance values are known as AC-IR when measured using the AC method, and as DC-IR when measured using the DC method. AC-IR and DC-IR have a complementary relationship, and it's recommended to choose the one that best suits your application, or to carry out both measurements. HIOKI battery testers can perform 4-terminal AC-IR measurement.



## $(1 \text{ m}\Omega \text{ and lower})$ for large batteries

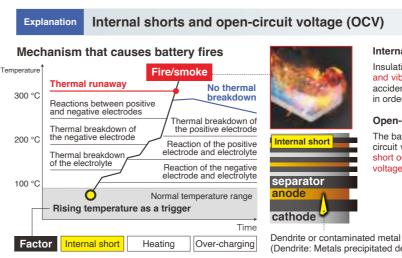
BT4560

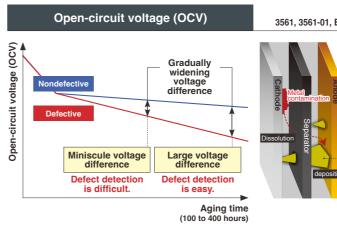
The larger the battery, the lower its internal resistance. Large batteries used in automobiles and infrastructure applications sometimes have internal resistance values of less than 1 mΩ. The BT4560's four-terminal-pair measurement method, which reduces the effects of induction fields, is an optimal solution for accurately measuring such low resistance levels.



## Measuring battery performance and safety

## Manufacturing highly safe batteries





## **High-accuracy OCV measurement**

		н	igh-accuracy
Model	BT3561A, BT3562-01, BT3562A, BT3563-01, BT3563A, BT3564	BT4560	DM7276 (DC VOLTMETER)
Appearance		an. Et it:	See .
Recommended range for 4 V measurement	6 V range	5 V range	10 V range
Number of digit, Max. Display	5 1/2 digit, 6.000 00	5 1/2 digit, 5.100 00	7 1/2 digit, 12.000 000
Resolution*1	10 µV	10 µV	1 µV
Basic accuracy <sup>1</sup>	±0.01% rdg ±3 dgt	±0.0035% rdg ±5 dgt	±0.0009% rdg ±12 μV
Measurement error'1 '2	±430 μV	±190 μV	±48 μV
Period of accuracy guarantee	1 year	1 year	1 year
Temperature measurement	N/A	YES	YES
Temperature Compensation Function	N/A	N/A	YES

\*1: When using recommended range for 4 V measurement \*2: When measuring a 4 V LIB cell

## Internal shorts

Insulation defects, which can be caused by factors such as ageing and vibrations during shipment, can lead to fire and other dangerous accidents, making it necessary to check open-circuit voltage values in order to distinguish between defective and non-defective products.

#### Open-circuit voltage (OCV)

The battery voltage when no load is connected is known as the opencircuit voltage (OCV). When an insulation defect such as an internal short occurs inside the battery, self-discharge causes the open-circuit voltage to decrease

(Dendrite: Metals precipitated dendritic form)

#### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276



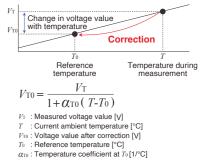
Since the amount of change in OCV caused by self-discharge is extremely small, it is necessary to age batteries at least 100 to 400 hours before testing can accurately distinguish between non-defective and defective products. Additionally, it is necessary to measure OCV multiple times during the aging process. Using an instrument with good accuracy makes it possible to remove defects from the testing line earlier in the process, significantly reducing management and testing costs.

## Dendrites form over time as minuscule metal fragment contaminants dissolve, leading to internal shorts.

### BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276

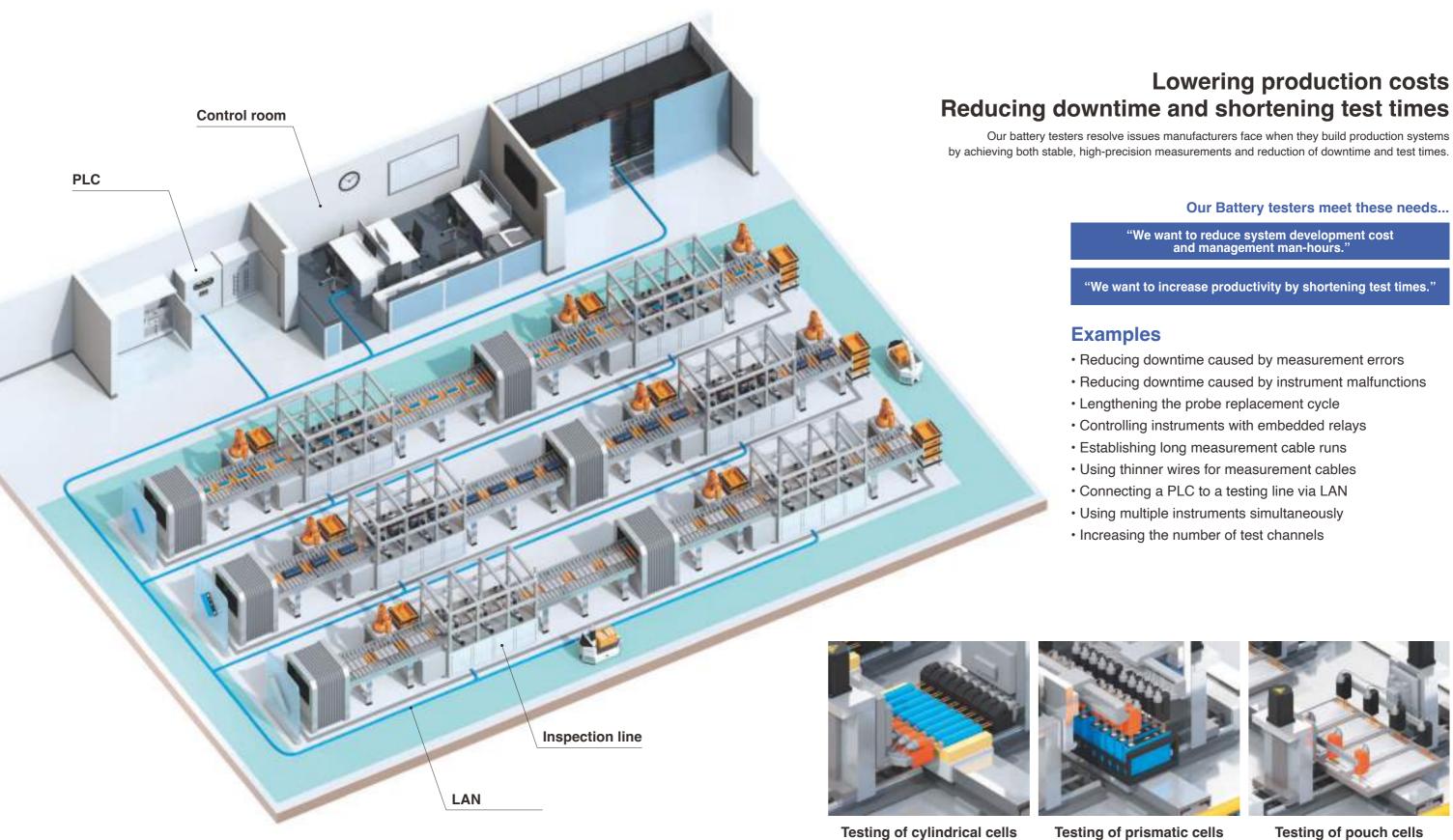
### OCV fluctuates with the ambient temperature

A battery's OCV value can fluctuate several hundred microvolts with a change of just 1°C in the ambient temperature. Temperature correction functionality allows the instrument to display a value that has been converted to the voltage at the reference temperature.



3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

## Integrate to automatic testing system



Testing of prismatic cells

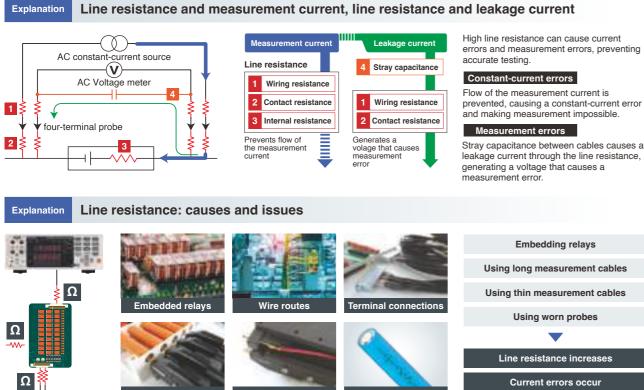
Testing of pouch cells

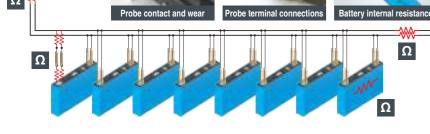
## Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system

## Reducing test system development cost and management man-hours





Increasing line resistance tolerances

BT3561A, BT3562A, BT3563A

 $\mathbf{\nabla}$ 

Lower

productivity

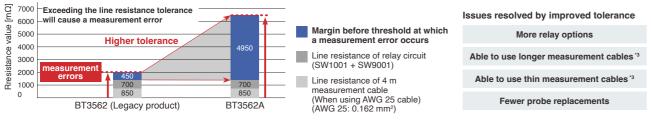
Measurement errors occur

More managemen

man-hours

The BT3561A, BT3562A and BT3563A have dramatically improved tolerances for line resistance compared to previous models. This improvement makes it easy to build test systems with large numbers of channels using relays. Additionally, a longer maintenance cycle for systems in use means fewer maintenance man-hours. Finally, its capability to handle thinner cables than with previous models<sup>3</sup> makes it easier to route cables.

(SENSE side when using 3 m $\Omega$  or 30 m $\Omega$  range)

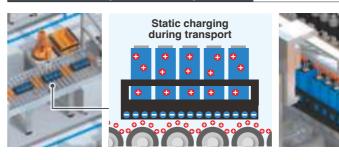


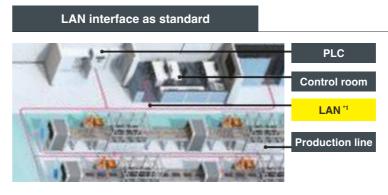
Model			3561, 3	3561-01			BT3	561A		B	T3562A	BT356	3A	BT3562	2-01, BT3	8563-01, I	BT3564
Range		3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω
Measurement current		N/A	N/A	10 mA	1 mA	N/A	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA
Allowable total line resistance	SENSE line	N/A	N/A	20 Ω	20 Ω	N/A	6.5 Ω	30 Ω	30 Ω	6.5 Ω	6.5 Ω	30 Ω	30 Ω	2Ω	2 Ω	15 Ω	15 Ω
(error detection) *1 *2	SOURCE line	N/A	N/A	50 Ω	500 Ω	N/A	5.5 Ω	15 Ω	150 Ω	5.5 Ω	5.5 Ω	15 Ω	150 Ω	2Ω	2Ω	15 Ω	150 Ω

\*1: Typical value \*2: Total line resistance = (Wiring resistance + Contact resistance + DUT resistance)

\*3: AWG 29 (0.064 mm<sup>2</sup>) wire equivalent to 2.2  $\Omega$  over an 8 m round trip can be used with the 3 m $\Omega$  or 30 m $\Omega$  range.

#### Preventing instrument malfunctions caused by static electricity

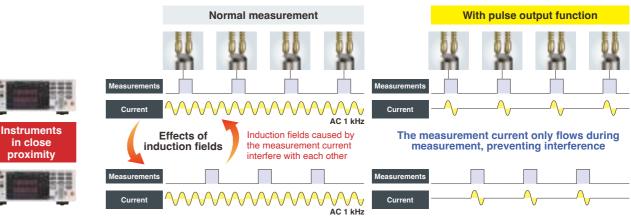






## Using multiple instruments simultaneously

When multiple battery testers are used at the same time, their induction fields can interfere with each other, causing measurement errors. Since the instruments' measurement currents flow continuously, such interference can occur even if measurements are timed so that they don't occur simultaneously. The measurement current pulse output function allows the measurement current to flow only during measurement. By using this function to make alternating measurements, you can avoid the effects of interference between induction fields caused by the measurement current.



### BT3561A, BT3562A, BT3563A



Batteries can become charged on production lines, for example, when being transported on a conveyor belt. When probes are placed in contact with such batteries, the resulting application of static electricity can then damage the instrument. The BT3561A, BT3562A and BT3563A are designed to withstand contact with  $\pm 30$  kV of static electricity\*, preventing static-caused malfunctions and reducing testing line downtime.

\* ±30 kV IEC 61000-4-2 contact discharge

#### BT3561A, BT3562A, BT3563A

The BT3561A, BT3562A and BT3563A are equipped with a LAN interface as standard equipment, making it easy for the instrument to interoperate with a PLC<sup>2</sup>based control system. The ability to use readily accessible LAN cables helps lower costs during system development and maintenance. Furthermore, a design with strong noise and static electricity resistance helps avoid system problems.

\*1: Max.30 m \*2: Programmable Logic Controller, a device that automatically controls one or more machines

## 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

OK

Accurate probing is essential for accurate measurement. Our battery testers are equipped with probe contact monitoring functionality to ensure highly reliable testing.

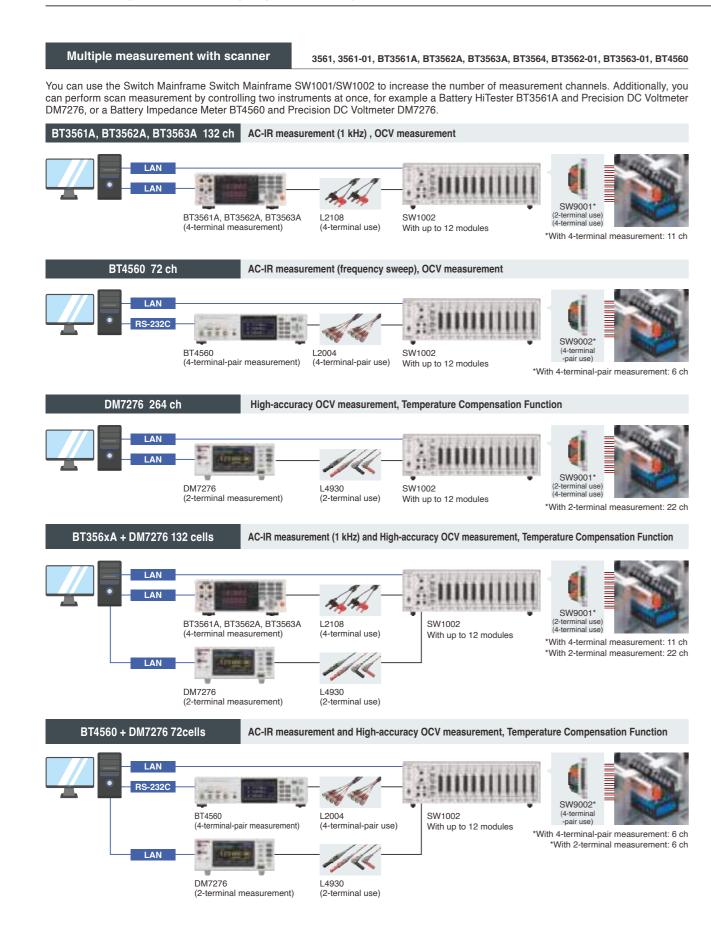
## BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

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3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing systems

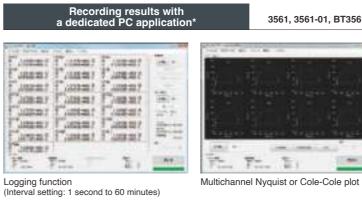
## Improving productivity by reducing test times

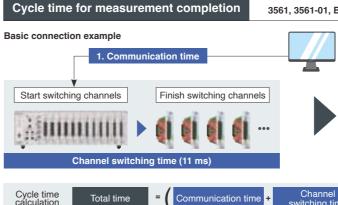


## Configuration Example of Multi-channel Battery Testing

oomiguia			initer battery ie	Stillg					
Instrument	Number of instruments in use	AC-IR measurement 1 kHz	AC-IR measurement frequency sweep	OCV measurement	High-accuracy OCV measurement Temperature Compensation Function	Connection cable	Switch mainframe	Module	Maximum number of channels
BT3561A									
BT3562A	1	YES	N/A	YES	N/A	L2108	SW1002	SW9001	132 ch
BT3563A	]								
BT4560	1	YES	YES	YES	N/A	L2004	SW1002	SW9002	72 ch
DM7276	1	N/A	N/A	N/A	YES	L4930	SW1002	SW9001	264 ch
BT3561A									
BT3562A	2	YES	N/A	YES	N/A	L2108	SW1002	014/0001	100 sh
BT3563A	(switched)						Switching instrument	SW9001	132 ch
DM7276	1	N/A	N/A	N/A	YES	L4930			
BT4560	2	YES	YES	YES	N/A	L2004	SW1002		
DM7276	(switched)	N/A	N/A	N/A	YES	L4930	Switching instrument	SW9002	72 ch
	BT3561A BT3562A BT3563A (4-terminal us		BT4560 (4-terminal-pair u	se)	DM7276 (2-terminal use)		111	¢	(
19 A	(+-terminal us	50)		3.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4		SW1002		SW9001	SW9002
ng ng	L2108 (4-terminal us	se)	L2004 (4-terminal-pair use)	1/4	L4930 (2-terminal use)	SW1001: acco	modates up to 12 SW9 modates up to 3 SW90 minal use, 4-terminal u	01 or SW9002 I	modules

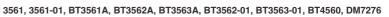






Instrument	Module	Number of channels	Function	Measurement speed	Measurement response time	Total time	(All channels)	Conditions
BT3562A	SW9001	11	OV	EX. FAST	10 ms	0.45 s	Approx. 41 ms/ch	Communication with BT3562A
D13302A	200001	11	120	MEDIUM	10 ms	1.1 s	Approx. 100 ms/ch	via RS-232C (38400 bps)
		6		FAST	0 ms	1.0 s	Approx. 167 ms/ch	Communication with BT4560
BT4560	SW9002	6	RX	MEDIUM	0 ms	1.2 s	Approx. 200 ms/ch	via USB (9600 bps) Measurement frequency: 1 kHz
		22		0.02 PLC*	0 ms	0.45 s	Approx. 20 ms/ch	Communication with
DM7276	SW9001	22	V	FAST	0 ms	0.85 s	Approx. 39 ms/ch	DM7276 via USB
		22		MEDIUM	0 ms	4.9 s	Approx. 223 ms/ch	Contact check: Off

\*Power Line Cycle 20 ms at 50 Hz, 16.7 ms at 60 Hz





## Logging function

Measure and log up to 264 channels.

## **OCV** measurement function

Measure OCVs, and additionally record the initial voltages and change rates as well.

## Multichannel Nyquist or Cole-Cole plot

Measure impedance while varying the frequency across up to 72 channels and display the results as a Nyquist or Cole-Cole plot.

\*PC application for SW1001/SW1002.

## 3. Com 2. Cor Check the contact Start Complete measurement Measurement response time Sa Number of channels Sampling time

## **Diagnosing degradation in batteries** BT3554-50





## Accurately diagnosing battery degradation in an operating UPS

Measuring the battery's internal resistance and voltage to determine whether it has degraded

Our Battery testers meet these needs...

"We want to detect battery degradation in an operating UPS."

"We want to complete an intensive inspection workload efficiently."

Completing an intensive inspection workload efficiently

You can efficiently inspect an enormous number of batteries, for example those found in UPS systems, with our free app "GENNECT Cross"

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16



Registration of profile information Location information Office Building East Wing Device information: UPS for server Battery number: 1 to 500



Up to 100 sets of profile information can be registered on the BT3554-50. Up to 500 data sets can be saved for each profile. (The BT3554-50 can save up to 6,000 data sets) Profile information can be registered on the

BT3554-50 from either GENNECT Cross or the desktop application GENNECT ONE.

The optional Wireless Adapter Z3210 is required in order to use the measurement and recording guidance function as well as other functions that communicate with smartphones or tablets.



[Next: battery No.1] Audio guida

Next: No.4 ····· "No.2 FAIL"

BT3554-50

Measurement data is recorded along with previously registered profile information.

Profile information	
Profile number	1
Location information	Office Building East Wing
Device information	UPS for server
Battery number	1
Measurement data	
Memory number	A.001
Data and time	2021/4/20 13:00:00
Resistance value	x.xxx mΩ
Voltage value	xx.xx V
Temperature	xx.xx°C
Comparetor Threshold value	x mΩ / x mΩ / x V
Judgement result	PASS/WARNING/FAIL

## Fit in tight spaces for speedy inspection



Easy data saving. Simply touch the leads to the terminals.

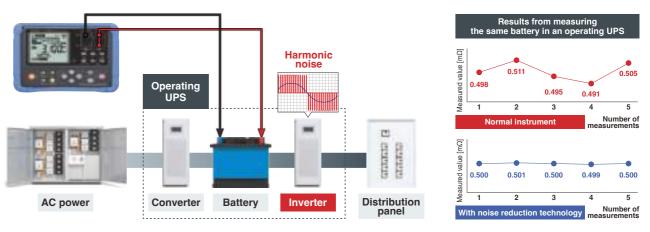
The instrument's auto-memory function, which automatically stores measured values resulting from the auto-hold function in its internal memory, further streamlines work tasks.

confined locations.

also available.

## Accurate measurement, even in a noisy environment

Inverters in operating UPS systems generate harmonic noise, and instruments usually have difficulties to make accurate measurements when affected by such noise. The BT3554-5x is able to measure accurately even when exposed to inverter noise thanks to its noise reduction technology.



P	Products Li	ineu	р			
			2	T		
Model No. (Order code)	BT	3554	1-92	B	T35	54-91
		Pin Ty L2020	ype Lead 0	, and the second		Type Lead 65-10
Included		Wirele Z321	ess Adapter 0			eless Adapter 210
accessories	Carrying Case C10	14	Protector Z5041	Fuse S Z5050	et	0 Adj Board

## BT3554-50



L-shaped lead for measurement in

The L2020 pin-type lead with an L-shaped tip is available as an accessory, making it easy to measure in confined locations. The pin-type lead 9465-10 with a straight tip is



Wall and shoulder straps let you work with both hands.

Use the included shoulder strap to carry the instrument with you while making measurements. Or use the Magnetic Strap Z5020 (sold separately) to hang the instrument on the wall while you work.

### BT3554-50



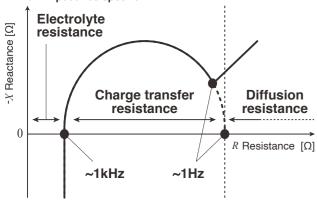
## **Analyzing batteries BT4560**



Assessing battery characteristics

The chemical reactions in batteries involve several processes and each process has its own reaction speed. Therefore by sweeping the frequency and measuring the impedance the characteristics of each part can be evaluated separately.

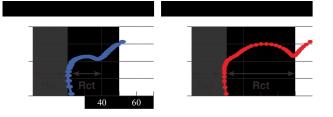
## Drawing a Nyquist or Cole-Cole plot with an impedance spectrum



### Check the battery deterioration level

The resistance of a degraded battery is significantly larger than a pristine one. The degradation of charge transfer resistance is particularly noticeable in the Nyquist or Cole-Cole plot for applications that involve charging/discharging at low temperatures or deep charging/discharging (SOC between 0% and 100%)

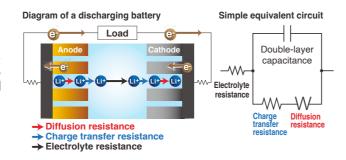
### Compare measured data for pristine and deteriorated batteries



Rel: Electrolyte resistance Rct: Reaction resistance

#### Li-ion diffusion in the electrode less than 1 Hz Low frequencies (Diffusion resistance) 1 Hz to several Intermediate Li-ion transfer hundred Hz frequencies (Charge transfer resistance) Li-ion transport in electrolyte High frequencies About 1 kHz (electrolyte resistance)

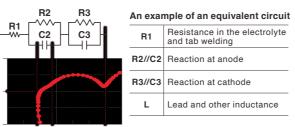
BT4560



### Idenfity battery deterioration factors

\*ZView® is a product of Scribner Associates, Inc.

An equivalent circuit analysis software (e.g. ZView®\*) can provide the parameters of each element of an equivalent circuit model by means of curve fitting. It allows you to see which part of the battery has shown characteristic changes. This serves to identify battery deterioration factors.



For more information about ZView®, please contact Scribner Associates, Inc.

## easurement frequencies and nce

The BT4560 offers measurements in the optimal frequency range for liquid Li-ion batteries. Its unparalleled capability to measure extremely low impedance is ideal for large cells such as ones for xEVs or ESSs. As a complementary instrument, the IM3590 offers impedance measurements across a wider frequency range. It is very capable at measuring larger impedance.

Model and specification	Measurement frequency	Measurable battery voltage	Impedance measurement ranges
BT4560	0.1 Hz to 1050 Hz	5 V	3 mΩ, 10 mΩ, 100 mΩ
Custom BT4560 (Measurable voltage 20 V)	0.1 Hz to 1050 Hz	20 V	30 mΩ, 300 mΩ, 3 Ω
Custom BT4560 (Measurable low frequency 10 mHz)	0.01 Hz to 1050 Hz	5 V	3 mΩ, 10 mΩ, 100 mΩ
Custom BT4560 (Measurable voltage 20 V and low frequency 10 mHz)	0.01 Hz to 1050 Hz	20 V	30 mΩ, 300 mΩ, 3 Ω
IM3590	1 mHz to 200 kHz	5 V	100 mΩ to 100 MΩ
····		 1	

BT4560 BATTERY IMPEDANCE METER IM3590

### **BT4560 Accuracy specifications**

## Impedance measurement accuracy

 $3 \text{ m}\Omega$  range (0.1 Hz to 100 Hz)  $10 \text{ m}\Omega$  range,  $100 \text{ m}\Omega$  range

 $R \text{ accuracy} = \pm (0.004 | R | + 0.0017 | X |) [m\Omega] \pm \alpha \qquad R \text{ accuracy} = \pm (0.004 | R | + 0.0052 | X |) [m\Omega] \pm \alpha$  $X \operatorname{accuracy} = \pm (0.004 | X | + 0.0017 | R |) [m\Omega] \pm \alpha \qquad X \operatorname{accuracy} = \pm (0.004 | X | + 0.0052 | R |) [m\Omega] \pm \alpha$  $Z \operatorname{accuracy} = \pm 0.4\% \operatorname{rdg} \pm \alpha \left( |\sin\theta| + |\cos\theta| \right)$  $\theta$  accuracy =  $\pm 0.1^{\circ} \pm 57.3 \frac{\alpha}{Z} (|\sin\theta| + |\cos\theta|)$ Accuracy graph

2.0

 $Z \operatorname{accuracy} = \pm 0.4\% \operatorname{rdg} \pm \alpha \left( |\sin\theta| + |\cos\theta| \right)$  $\theta$  accuracy =  $\pm 0.3^{\circ} \pm 57.3 \frac{\alpha}{Z} (|\sin\theta| + |\cos\theta|)$ 

Accuracy graph

			i	
	11		!	
			i	
	11		!	
			i	
	1 1		!	
			.7	
		·	$\overline{\nabla}$	
$X \longrightarrow F$	2			
-90	0	90	180	
		Phas	<b>□</b> [0]	

when sen-ce	anoration is perion	neu)
v	Display range	-5.10000 V to 5.10000 V
v	Resolution	10 µV
Voltage accuracy	FAST/MED/SLOW	±0.0035% rdg ±5 dgt
Temperature coefficient	±0.0005% rdg ±1 dg (applied in the ranges of	gt / °C f 0°C to 18°C and 28°C to 40°C)

## Measuring the internal resistance of fuel cells

The BT3563-01/BT3564 with special edition specifications features increased noise resistance to reduce the effects of noise from load devices. The instrument can ascertain fuel cell state based on impedance measured at a frequency of 1 kHz.

## Assess fuel cell characteristics in real time while under load



Impedance accuracy excluding  $\alpha$ (0.004 | R | + 0.0017 | X |, 0.004 | X | + 0.0017 | R |) Voltage measurement accuracy

## (BT4560 + Z2005 temperature sensor)

±0.5°C (measurement temperature: 10.0°C to 40.0°C) Accuracy ±1.0°C (measurement temperature -10.0°C to 9.9°C, 40.1°C to 60.0°C) Temperature ±0.01°C/°C

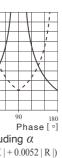
Impedance accuracy excluding  $\alpha$ (0.004 | R | + 0.0052 | X |, 0.004 | X | + 0.0052 | R |)

### BT4560, IM3590

CHEMICAL IMPEDANCE ANALYZER

Probes for measurement are not included. Please purchase a probe according to your measurement application. (Learn more P.22 to P23)

### $3 \text{ m}\Omega$ range (110 Hz to 1050 Hz)



The units of R and X are  $[m\Omega]$ ,  $\alpha$  is as shown below

	,						
Range		3 mΩ	10 mΩ	100 mΩ			
α	FAST	25 dgt	60 dgt	60 dgt			
	MED	15 dgt	30 dgt	30 dgt			
	SLOW	8 dgt	15 dgt	15 dgt			
Temperature coefficient		$\begin{array}{l} R: \pm R \mbox{ accuracy } \times 0.1 \ / \ ^{\circ} C \\ X: \pm X \mbox{ accuracy } \times 0.1 \ / \ ^{\circ} C \\ Z: \pm Z \mbox{ accuracy } \times 0.1 \ / \ ^{\circ} C \\ \theta: \pm \theta \mbox{ accuracy } \times 0.1 \ / \ ^{\circ} C \mbox{ (Applied in the ranges of 0^{\circ} C to 18^{\circ} C \mbox{ and } 28^{\circ} C \mbox{ to 40 } ^{\circ} C) \end{array}$					

#### The number of waveforms

	FAST	MED	SLOW
0.10 Hz to 66 Hz	1 wave	2 waves	8 waves
67 Hz to 250 Hz	2 waves	8 waves	32 waves
260 Hz to 1050 Hz	8 waves	32 waves	128 waves

## Temperature measurement accuracy

coefficient (applied in the ranges of 0°C to 18°C and 28°C to 40°C)

## BT3563-01 (Special edition specifications), BT3564 (Special edition specifications)

BT3563-01 or BT3564 (special edition specifications)

Measurement of fuel cell's internal resistance



Web application "Multi-plot"

## Converting measurement data into a Nyquist or Cole-Cole plot

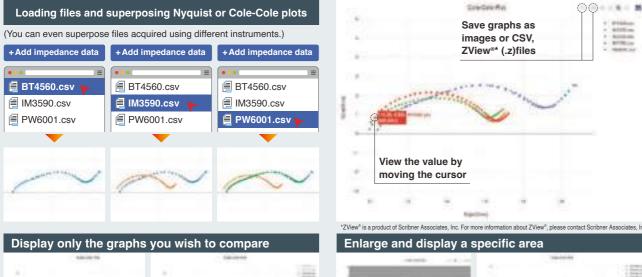
web browser link

https://www.circuitfitting.net/multiplot

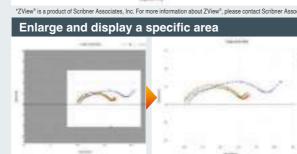
"Multi-plot", a free web application, enables you to draw a Nyquist or Cole-Cole plot simply by loading a file in your web browser. Supported files: CSV file, ZView®\* (.z) file



Draw Nyquist or Cole-Cole plots freely, without any limits on the number of points that can be rendered from files or the number of graphs that can be superposed. The horizontal and vertical axes are automatically scaled based on the graphs being rendered. You can even superpose, compare, and analyze files acquired using different instruments.

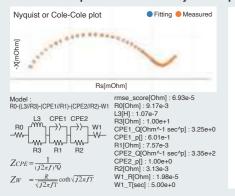


# 100 Column Instantian and



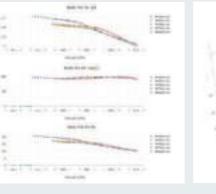
## Analysis function

## Conduct an equivalent circuit analysis



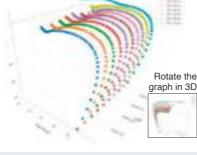
Analyze the data with predefined models. Bode plots are also drawn, enabling to Draw 3D Nyquist or Cole-Cole plots or 3D Display analysis results automatically assess phase characteristics. simply by loading a file.

### Draw Bode plots to assess phase characteristics





Analyze characteristics with 3D view



Bode plots, using the time or date as a third axis. Rotate 3D graphs in any direction as desired and save images.

## Internal resistance and open-circuit voltage for various battery types and compatible instruments







The BT3564 can safely test high-voltage battery packs such as infrastructure storage batteries

lischarges, which are prone to occur during high-voltage measurement, by limiting the amount of current that flows the instant contact is established with a battery pack.

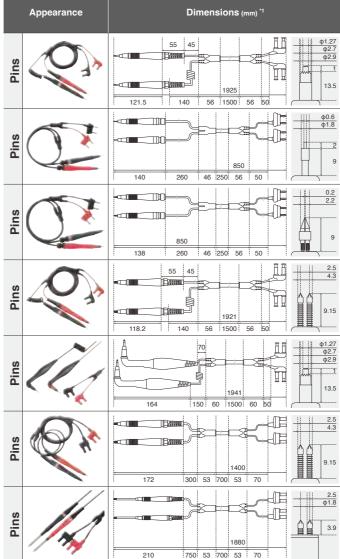


probe is designed to accommodate battery packs whose terminals are placed far apart.

## Measurement lead and measurement probe compatibility chart

- YES : Recommended measurement lead or probe.
- N/A : Not compatible due to inability to connect.
- \*1 : Although it can be connected, it may not meet the product specifications, such as accuracy guarantee.
- May be susceptible to external noise. \*2 : Caution is particularly required when using a measurement current of 10 mA or less.
- \*3
- BNC banana plug adapter (custom-made) Connect the black banana plugs to the HCUR and HPOT terminals to reduce the influence of external noise.
- \*4 : Temperature sensor cannot be connected.
- \*5 : It does not use a 4-terminal-pair design, so wiring placement will have a greater effect on measured values.
- \*6 : Some measurement ranges cannot be used due to rated current limitations.

	Appearance Dimensions (mm) <sup>-1</sup>		Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
Clips	Mart -	1350 131 300 56 700 56 700	<b>9467</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	YES
Clips	MAR.		<b>9460</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	*1 *4	*1 *4	*1 *4	*1 *2 *3 *5	YES
Clips		1000 85 188 35 630 62	L2000 ±42 V peak AC+DC (Hi-to-Lo) ±42 V peak AC+DC (voltage to earth)	N/A	N/A	N/A	*1 *6	N/A
Clips			L2002 ±30 V peak AC+DC (Hi-to-Lo) ±30 V peak AC+DC (voltage to earth)	N/A	N/A	N/A	YES	N/A
Pins		¢1.8 9.15	L2003 ±30 V peak AC+DC (Hi-to-Lo) ±30 V peak AC+DC (voltage to earth)	N/A	N/A	N/A	YES	N/A
Clips	- And	1100 84 130 745 85	L2107 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
Pins	D		<b>9452</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	*1	*1	*1 *2 *3 *5	*1
Clips • Pins			<b>9453</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
Pins			<b>9455</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	*1	*1	*1 *2 *3 *5 *6	*1
Pins	n.		9461 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	*1



	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
27 .7 .9 .1	9465-10 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
6 8 2 9	<b>9770</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
9	<b>9771</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
.5	<b>9772</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
27 .7 .9 .1	<b>L2020</b> 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
15	L2100 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	*1 *2 *3 *5	*2
.5	L2110 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	N/A	N/A

## Batteries are a driving force for a variety of innovations as we move towards a sustainable society

Batteries are used in an array of applications, and their performance can be a driving force for a variety of innovations and new lifestyles. The development and production of high-quality batteries will play an essential role as we work to realize a sustainable society. At the same time therefore, growing improvements in battery life cycle assessment have become a major priority. the focus on reducing CO2 emissions throughout the entire life cycle by means of improvements in manufacturing processes and reuse of high-quality batteries is increasing. HIOKI battery testers are helping resolve these issues through an electrical measurement approach.

Stacked battery voltage, Internal resistance of battery cells



Scan for all regional contact